



# IECQ QUALITY ASSESSMENT SYSTEM (IECQ)

For rules and details of the IECQ visit [www.iecq.org](http://www.iecq.org)

## IECQ Certificate of Approval Independent Testing Laboratory

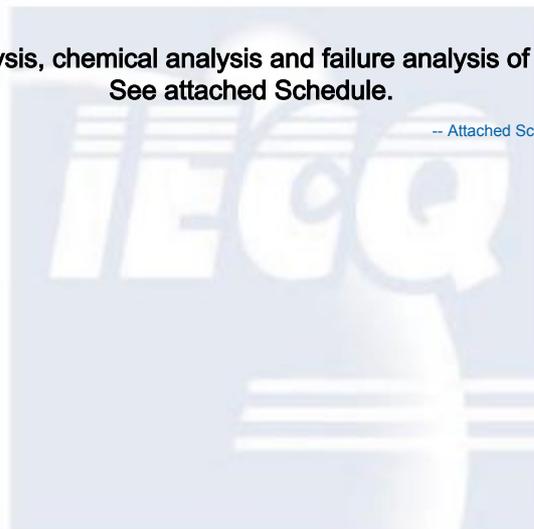
IECQ Certificate No.:	IECQ-L ULTW 16.0003-02	Issue No.:	7	Status:	Current
Additional Site to Certification: IECQ-L ULTW 16.0003		Originally Issued: 2016/07/28			
Supersedes:	<a href="#">IECQ-L ULTW 16.0003-02 Issue 6</a>	Issue Date:	2024/08/29	Site Added:	2016/07/28
CB Reference No.:	20002490 ITL	Expiration:	2025/07/27		

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The organization, facilities and procedures have been assessed by the IECQ Certification Body in accordance with IECQ 03-1 and IECQ 03-6 for issuance of this certificate and found to be in conformity with the applicable requirements of the IECQ Independent Testing Laboratory Assessment Program Requirements Scheme and in respect of ISO/IEC 17025:2017 for the testing of component product under the IECQ.

**Scope:**  
 The materials analysis, chemical analysis and failure analysis of semiconductors.  
 See attached Schedule.

-- Attached Schedule: IECQ-L\_ULTW\_20002490 ITL\_08-29-24.pdf --



**Approved by Certification Body (CB): DQS Group - DQS Taiwan Inc.**

8F, 23, Yuan Huan West Road,  
 Feng Yuan Dist., Taichung City  
 Taiwan

Authorized person:  
**Bob CHEN**



The validity of this certificate is maintained through on-going surveillance audits by the IECQ CB issuing this certificate.  
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# IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,  
Assemblies, Related Materials and Processes

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## Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 16.0003-02

CB Certificate No.: 20002490 ITL

Schedule Number: IECQ-L ULTW 16.0003-02-S Rev No.: 7 Revision Date: 2024/08/29 Page 1 of 1

### Appendix-1 (20002490 ITL)

### Schedule of Scope to Certificate of Approval

Description test	Standard
Scanning Electron Microscope (SEM)	T-SEM-3
Energy Dispersive Spectrometry of X-ray (EDS)	T-SEM-3, T-TEM-3
Focused Ion Beam microscope (FIB)	T-FIB-3
X-Ray imaging	T-EFA-3
Scanning Acoustic Tomography (SAT)	T-EFA-3
Optical Microscope (OM)	T-OMI-3
3D Optical Microscope (3D OM)	T-LAB-3
IC Layout Imaging	T-OMI-3
Circuitry analysis	T-OMI-3

Technical Reviewer of DQS: Paul Yang Date: 8/29/2024

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DQS-Group - DQS Taiwan Inc., Feng Yuan Dist., Taichung City, Taiwan

